

Silicon isotope separation in a SiF₄ molecular jet by two-frequency IR multiphoton dissociation

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Abstract We performed Silicon isotope separation SiF₄ in a molecular jet by two frequency infrared multiphoton dissociation, using two TEA CO₂ laser. The dissociation process was monitored with a Time-of-Flight mass spectrometer by UV multiphoton ionization, using the fourth harmonic of a pulsed Nd:YAG laser. The dissociation yield and enrichment factor has been studied in terms of the lasers fluence, wavenumber and delay time. The results shows a remarkable increase in the dissociation yield and enrichment factor in the two-frequency technique compare with the single-frequency IRMPD.

1 Introduction

Silicon isotope enrichment

Laser Isotope techniques

Infrared multiphoton ionization for silicon compounds

Two-frequency multiphoton ionization

We have studied the two-frequency IRMPD of SiF₄ in a molecular jet. The dissociation efficiency and the enrichment factor were characterized with time of flight mass spectrometry (TOF). The analysis of those main characteristics required the definition of estimators that discount the background signal.

2 Experimental approach

A scheme of the experimental setup is shown in Figure 1. Two home-built TEA CO₂ laser were used as the excitation and dissociation sources. The excitation laser was tuned close to the Si-F stretching mode (ν_3) to perform a vibrational excitation of the molecule. Furthermore, the dissociation laser was red shifted to a lower wave

number from the ν_3 vibrational mode. Both lasers have stable optical resonators and are focused through a 10 cm focal length ZnSe lens, in a collinear configuration.

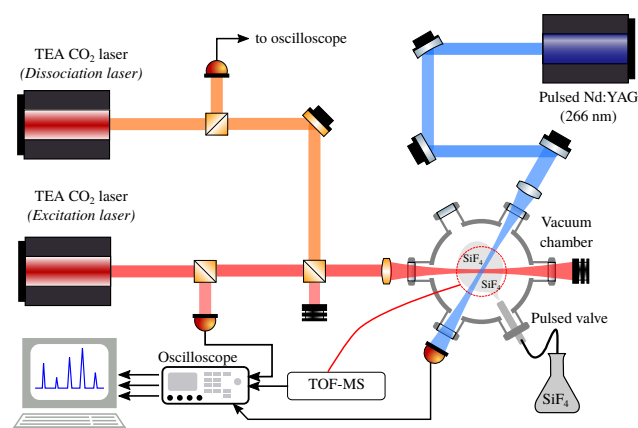


Fig. 1 Experimental setup for the two frequency IRMPD over a molecular jet of SiF₄.

A sample of SiF₄ (99 % Matheson) at a total pressure of 500 Torr was expanded through a pulsed valve (Parker Hannifin Corporation) into a stainless steel vacuum chamber, evacuated by a turbo-molecular pump (pump Brand). The average pressure in the molecular jet is estimated to be less than 1×10^{-4} Torr [?]. Downstream, the molecular jet is crossed by the excitation and dissociation lasers and the ionization laser.

The generated ions are collected by an extractor potential into a Time of Flight Mass Spectrometer (Kore Technology) until they reach the ion detector. The obtained spectrum signals were recorded by an oscilloscope (Tektronix, DPO 7104 1GHz). We operate the CO₂ lasers at 1 Hz and the UV ionization laser at 2 Hz in order to discount the background on alternative shots.

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2.1 Mass Spectrum analysis

The irradiation of the molecular jet by the 266 nm UV laser produce a ionization but also a fragmentation of the SiF_4 . Figure 2 shows a typical mass spectrum of the sample irradiated only by the UV laser. This pattern has no peak in the 104 mass, which implies that it has no parent. Also it can be seen that the highest peak corresponds to the $[\text{SiF}^+]$ ion so the amplitude of the peak is used as an estimator of the concentration.

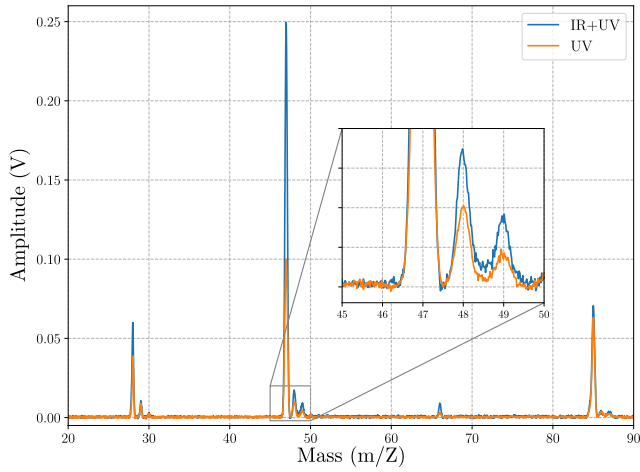
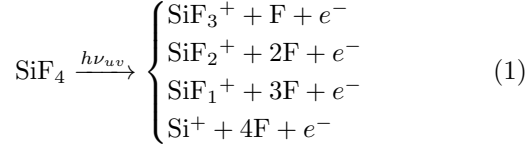
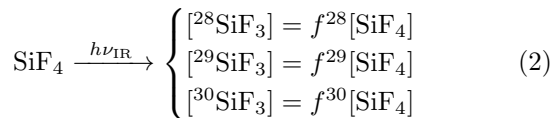
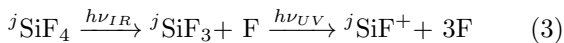


Fig. 2 SiF_4 mass spectrum obtained with 266 nm multi-photon ionization.

In the following experiments the SiF_4 molecular jet is first irradiated by IR radiation, to dissociate the molecule, and then the came the UV ionization to analyze the fragments in the TOF-MS. The IR lasers performs the following dissociation probability (f^i) for each isotope specie,



After this fragmentation, the sample is irradiated with the UV laser to ionize the sample but it also leads to another fragmentation.



Summarizing, the total signal (I^T) in the SiF^+ is a combination of both processes.

$$I^T = K p_{\text{SiF}_3}^{\text{SiF}^+} f^{28}[\text{SiF}_4] + K p_{\text{SiF}_4}^{\text{SiF}^+} (1 - f^{28})[\text{SiF}_4] \quad (4)$$

where K is an instrument constant, related to the ion counting convertor and the data acquisition.

In order to characterize the dissociation yield of the IRMPD process, we define the α_j estimator. This is the ratio between the total mass spectrum and the UV spectrum.

$$\alpha_j = \begin{cases} \alpha_{47} = (q-1)f^{28} \\ \alpha_{48} = (q-1)f^{29} \\ \alpha_{49} = (q-1)f^{30} \end{cases} \quad (5)$$

As can be seen, α_j is proportional to f^j and q is the ratio between ionization probabilities of SiF_4 and SiF_3 . In the same way, is possible to define the isotope selectivity estimator β ,

$$\beta_k = \begin{cases} \beta_{29} = \frac{\alpha_{47}}{\alpha_{48}} = \frac{f^{28}}{f^{29}} \\ \beta_{30} = \frac{\alpha_{47}}{\alpha_{49}} = \frac{f^{28}}{f^{30}} \end{cases} \quad (6)$$

Justificación para decir que vamos a analizar solamente el estimador α_{47} y el estimador β_{30}

3 Results and discussion

3.1 Delay time laser dependence

The first parameter we analyzed in the IRMPD process was the delay between the TEA CO_2 lasers. The excitation laser is tuned to $\nu_e = 1031.5 \text{ cm}^{-1}$ and the dissociation laser to $\nu_D = 983 \text{ cm}^{-1}$. The fluence for both lasers where $\Phi_E = 120 \text{ J/cm}^2$ and $\Phi_D = 120 \text{ J/cm}^2$.

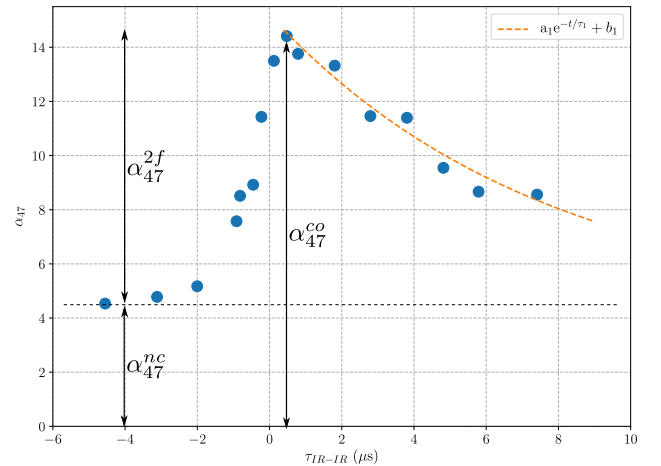


Fig. 3 Pulse delay dependence of the dissociation yield (α_{47} estimator) We define de pulse delay relative to the beginning of the excitation laser.

The α estimator shows a plateau for delay times between $-4 \mu\text{s}$ and $-2 \mu\text{s}$, related to the dissociation rates of each IR laser. Since the overlap of the two pulses we find a peak in α , due to the two-frequency IRMPD. As we mention in the previous section, the first IR laser

send molecules to the quasi-continuum and the second dissociates those excited molecules.

In order to obtain the pure contribution of the two frequency process, we make alternative measurements of "cooperative" and "non cooperative" situations. In the first one both lasers overlaps in the time domain and the delay is close to zero. While in the non cooperative case the delay is around $-4 \mu\text{s}$. By making the difference of those situation we obtain α^{2f} .

$$\begin{aligned}\alpha^{co} &\rightsquigarrow \alpha^{2f} + \alpha^E + \alpha^D \\ \alpha^{nc} &\rightsquigarrow \alpha^E + \alpha^D\end{aligned}\quad (7)$$

Figure 3 also shows the α decay which is fitted by an exponential function. The decay constant is $(7.8 \pm 0.4) \mu\text{s}$, five times larger than the tail of the IR lasers pulse. However, this decay time is in full agreement with the transit time of the molecular jet through the irradiation volume[cita].

3.2 Laser fluence dependence

In Figure 4 we show the α_{47}^{2f} estimator's dependency with the dissociation laser fluence (Φ_D). The experimental data is fitted by a power law function which is shown in orange dashed line. The exponent obtained is $a = 0.49 \pm 0.02$, in full agreement with previous works [CITA GRUPO].

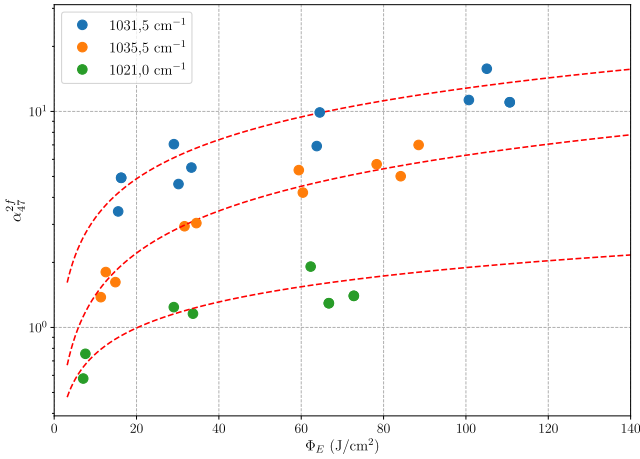


Fig. 4 Dissociation yield estimator as a function of the dissociation laser fluence.

Although the power law function fits the experimental data points, we are not able to reach a saturation of the dissociation estimator.

3.3 Laser wavenumber dependence

In general, the IRMPD dissociation probability shows a red shifted compare with normal modes oscillation frequencies; mainly due to the vibrational anharmonicity.

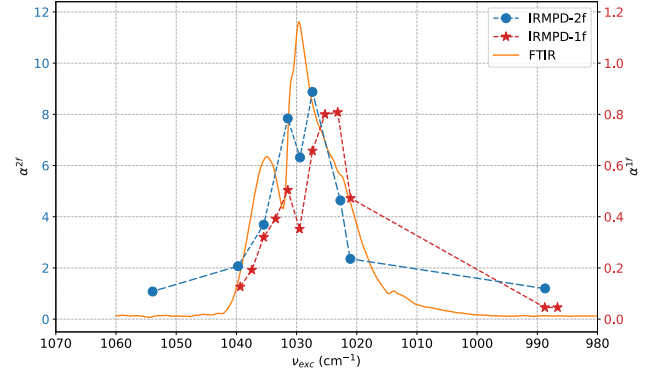


Fig. 5 Dependence of the α_{47} estimator on the excitation laser frequency (blue dots) compare with the linear absorption IR spectrum of SiF₄.

Figure 6 shows the α_{47}^{2f} estimator as a function of the dissociation laser wavenumber superimposed with the IR linear absorption spectrum. The fluences of the excitation and dissociation lasers were 50 J/cm^2 and 60 J/cm^2 , and the delay was fixed at $1 \mu\text{s}$. As can be seen, the dissociation yield presents a resonance close to 980 cm^{-1} which is almost 50 cm^{-1} red-shifted compared to the IR linear absorption spectrum. This result indicates that the SiF₄ has been excited to the vibrational quasicon- tinuum by the excitation laser.

As a rule of thumb we can assume a linear anharmonicity of the vibrational levels, founded on the Morse potential. In the SiF₄ case, the anharmonicity constant is $\chi_e \nu_3 \simeq 5 \text{ cm}^{-1}$, so we can estimate that the molecule has been excited up to the $\nu_{SF} = 10$.

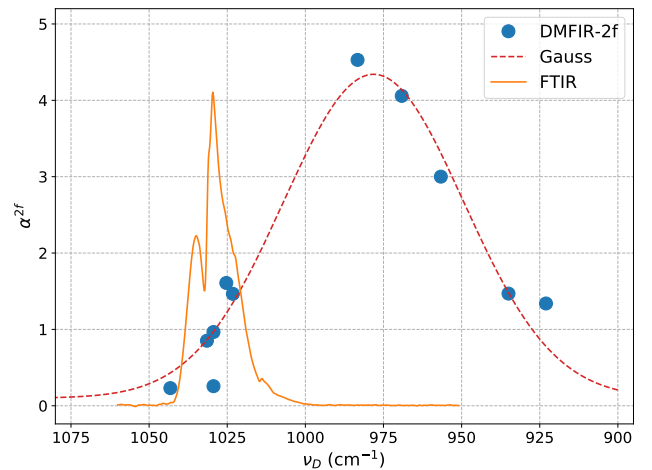


Fig. 6 Dependence of the α_{47} estimator on the dissociation laser frequency (blue dots) together with a gaussian distribution fit (orange dashed line), and the linear absorption IR spectrum of the ν_3 absorption line.

3.4 Enrichment factor

In Figure 7 the enrichment factor β_{30} is plotted against the excitation and the dissociation wavenumber. The factor shows a resonance as a function of ν_e with an slightly red shift compared with Si-F stretching normal mode. On the other side, the resonance is shifted almost 50 cm^{-1} in terms of the dissociation laser wavenumber.

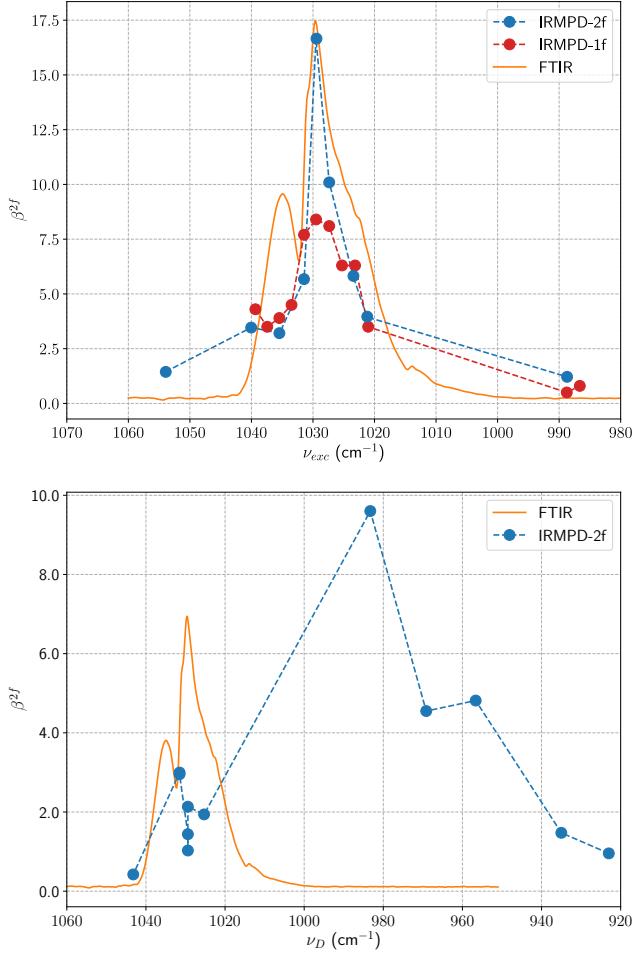


Fig. 7 Isotope enrichment factor as a function of lasers wavenumber. In the upper plot we show β_{30} dependence with the excitation laser wavenegth. Below, the β_{30} as a function of the dissociation laser wavelength. Both are compared with the IR linear absorption spectrum of SiF_4 .

Comment about the improvement of the β estimator

4 Conclusions

References

1. Author, Journal **Volume**, (year) page numbers.
2. Author, *Book title* (Publisher, place year) page numbers